PCN N	lumber:	201	40319001A						PCN Dat	te:	05/15/2014
Title:	Add Cu as Alternative Wire Base Metal for Selected Device(s) on QFN, QFP and SOT-23 packages										
Custo	mer Contact:	PCN	<u>Manager</u>		Phone:	+1(214)480-60	37		Dept:	Quali	ty Services
Propo	sed 1 st Ship D	ate:	08/15/201	4	Estimat	ed Sample Ava	ilal	oili	ity:		provided at ole request
Chanc	је Туре:		l							Samp	ne request
	Assembly Site				Design			١	Wafer Bu	mp Si	te
	Assembly Proc	ess			Data She	et			Wafer Bu		
\boxtimes	Assembly Mate	erials			Part num	ber change		١	Wafer Bu	mp Pr	ocess
	Mechanical Sp	ecifica	tion		Test Site			١	Wafer Fa	b Site	
	Packing/Shipp	ing/La	beling		Test Proc	ess		_	Wafer Fa		
								١	Wafer Fa	b Proc	ess
					PCN D	etails					
Descr	iption of Chan	ge:									
Texas device piece piece Group	Retracted devi Additional devi Instruments is s listed in "Processart changes as 1 Device: No 2 Device: Changes	please luct af follov other anges	devices und vith strikething ighlighted in ed to annour fected" sectivs. r piece part s Wire Com From 0.96 m	rouge rouge n year nce iii on miii A	Group 3 in the and high and hi	th were inadverted the Product Affeother Product	an an an ir	add	Section. ditional be urrent as	ond w sembl	ire option for y facility and
Reaso	n for Change:	•	, ,			,					
1) To ele 2) Ma 3) Cu Antici None.	ctrical propertie ximize flexibilit is easier to obt	es y with ain ar on Fit	in our Assen id stock :, Form, Fu	nbly ncti	//Test pro	ity or Reliabilit					tive):
Cirality	jes to product	-ueii	cacion re	-3u	iting iron	ii ciiis i cit.					

None.

Product Affected: Group 1 devices - No other piece part change, Only Au to Cu wire						
TPS65633ARTER TPS65633RTER TPS65633RTET						
		ire Composition and Wire Diameter				
			Diameter			
		RV91670PHPR				
Product Affected: Group 3 devices - Changes Mold Compound, Wire Composition and Wire Diameter						
74AHC1G125DBVRE4	SN74AHC1G08DBVR	SN74LVC1G32DBVRG4	TS5A4594DBVRE4			
74AHC1G125DBVRG4	SN74AHC1G08DBVRE4	SN74LVC1G34DBVR	TS5A4594DBVRG4			
74AHC1G126DBVRE4	SN74AHC1G08DBVRG		SN74AHC1G02DBVT			
74AHC1G126DBVRG4	SN74AHC1G125DBVR	SN74LVC1G34DBVRG4	SN74AHC1G86DBV6			
74AHC1GU04DBVRE4	SN74AHC1G126DBVR	SN74LVC1G66DBVR	SN74AHC1G86DBVT			
74AHC1GU04DBVRG4	SN74AHC1G86DBVR	SN74LVC1G66DBVRE4	SN74AHC1GU04DBVT			
74AHCT1G00DBVRE4	SN74AHC1G86DBVRE4		SN74AHCT1G00DBVT			
74AHCT1G00DBVRG4	SN74AHC1G86DBVRG4		SN74AHCT1G04DBVT			
74AHCT1G04DBVRE4	SN74AHC1GU04DBVR	SN74LVC1G79DBVRE4	SN74AHCT1G125DBVT			
74AHCT1G04DBVRG4	SN74AHCT1G00DBVR	SN74LVC1G79DBVRG4	SN74AHCT1G86DBV6			
74AHCT1G08DBVRE4	SN74AHCT1G04DBVR	SN74LVC1G80DBVR	SN74AHCT1G86DBVT			
74AHCT1G08DBVRG4	SN74AHCT1G08DBVR	SN74LVC1G80DBVRE4	SN74AUC1G04DBVR			
74AHCT1G125DBVRE4	SN74AHCT1G125DBVR		SN74AUC1G08DBVR			
74AHCT1G125DBVRG4	SN74AHCT1G126DBVR		SN74AUC1G125DBVR			
74AHCT1G126DBVRE4	SN74AHCT1G32DBVR	SN74LVC1G86DBVRE4	SN74AUC1G240DBVR			
74AHCT1G126DBVRG4	SN74AHCT1G86DBVR	SN74LVC1G86DBVRG4	SN74AUP1G04DBVT			
74AHCT1G32DBVRE4	SN74AUP1G04DBVR	SN74LVC1GU04DBVR	SN74AUP1G14DBVR			
74AHCT1G32DBVRG4	SN74AUP1G04DBVRE4		SN74AUP1G32DBVR			
74AHCT1G86DBVRE4	SN74AUP1G04DBVRG4		SN74AUP1G34DBVR			
74AHCT1G86DBVRG4	SN74AUP1G07DBVR	TL343IDBVRG4	SN74CBT1G384DBVR			
74AUP1G125DBVRE4	SN74AUP1G07DBVRE4		SN74CBT1G384DBVT			
74AUP1G125DBVRG4 74CBT1G125DBVRE4	SN74AUP1G07DBVRG4 SN74AUP1G125DBVR	TL431ACDBVRE4 TL431ACDBVRG4	SN74CBTD1G125DBVR SN74CBTD1G125DBVT			
74CBT1G125DBVRG4	SN74A0P1G123DBVR	TL431CDBVRG4	SN74CBTD1G123DBVT			
74CBTLV1G125DBVRG4	SN74CBTIG123DBVR SN74CBTLV1G125DBV		SN74CBTD1G364DBVR SN74LVC1G02DBVT			
74CBTLV1G125DBVRG4	SN74CBTEV1G123BBV SN74LVC1G02DBVR	TL431CDBVRG4	SN74LVC1G02DBVT			
74LVC1G126DBVRE4	SN74LVC1G02DBVRE4		SN74LVC1G00DBVT			
74LVC1G126DBVRG4	SN74LVC1G02DBVRG4		SN74LVC1G132DBVT			
74LVC1G120DBVRG4	SN74LVC1G02DBVRG4	TL431IDBVRG4	SN74LVC1G132DBV1			
74LVC1G132DBVRG4	SN74LVC1G06DBVRE4		SN74LVC1G240DBVT			
74LVC1G240DBVRE4	SN74LVC1G06DBVRG4		SN74LVC1G32DBVT			
74LVC1G240DBVRG4	SN74LVC1G07DBVR	TLV431AIDBVRG4	SN74LVC1G34DBVT			
74LVC1GU04DBVRE4	SN74LVC1G07DBVRE4		SN74LVC1G66DBVT			
74LVC1GU04DBVRG4	SN74LVC1G07DBVRG4		SN74LVC1G79DBVT			
SN003166DBVR	SN74LVC1G126DBVR	TLV431CDBVRG4	SN74LVC1G80DBVT			
SN1003028DBVR	SN74LVC1G132DBVR	TLV431IDBVR	SN74LVC1G86DBVT			
SN74AHC1G02DBVR	SN74LVC1G14DBVR	TLV431IDBVRE4	SN74LVC1GU04DBVT			
SN74AHC1G02DBVRE4	SN74LVC1G14DBVRE4		TL431CDBVT			
SN74AHC1G02DBVRG4	SN74LVC1G14DBVRG4		TS5A4595DBVR			
SN74AHC1G04DBVR	SN74LVC1G240DBVR	TS5A3166DBVRE4				
SN74AHC1G04DBVRE4	SN74LVC1G32DBVR	TS5A3166DBVRG4				
SN74AHC1G04DBVRG4	SN74LVC1G32DBVRE4					

Qualification Data: Group 1 Devices

This qualification has been developed for the validation of this change. The qualification data						
validates that the proposed change meets the applicable released technical specifications.						
Qu	Qual Vehicle 1: TPA2017D2RTJ (MSL 2-260C) Package Construction Details					
Assembly Site: TI-Clark Mold Compound: 4208625						
, and the second		Mount Compour				
# Pins-Designator, Family:	20-RTJ, QFN	•				Cu
Lead frame (Finish, Base): NiPdAu, Cu Bond Wire: 0.96 Mil Dia., Cu Qualification: Plan						
Sample Size/Fail						/:I
Reliability Test	Conditions			San		raii
, , , , , , , , , , , , , , , , , , , ,			Lo	t# 1	Lot# 2	Lot# 3
**High Temp Storage Bake	170C (420 Hrs)		8	6/0	87/0	87/0
**Autoclave	121C (240 Hrs)		8	7/0	87/0	87/0
**T/C -65C/150C	-65C/+150C (500 Cy	/c)	7	7/0	77/0	77/0
X-ray	(top side only)			5/0	5/0	-
Salt Atmosphere	24 Hours			2/0	22/0	22/0
Surface Mount Solderability 8 Hours Steam Age-Pb Free Solder 22/0 22/0				22/0		
Manufacturability (Assembly					Pass	Pass
Moisture Sensitivity		(level 2 @ 260C peak +5/-0C)			12/0	12/0
Notes **- Preconditioning sequence: Level 2-260C.						
Qual Vehicle 2: TPS2543QRTE (MSL 2-260C)						
Package Construction Details						
Assembly Site:	TI-Clark	Mold Compour				
# Pins-Designator, Family:	16-RTE, QFN	Mount Compour				
Lead frame (Finish, Base):	NiPdAu, Cu	Bond Wi	re:	2.0 M	1il Dia., C	u
Qualification:	Test Results					
Poliability Toot	Conditions		Sam		Sample Size/Fail	
Reliability Test	Conditions		Lot# 1		Lot# 2	Lot# 3
** Life Test	150C (408 Hrs)	150C (408 Hrs) 77/0 77/0 77/				77/0
**High Temp Storage Bake	175C (500 Hrs)		7	8/0	80/0	79/0
**Autoclave 121C (240 Hrs)			87/0		87/0	87/0
**Biased HAST	130C/85%RH (96 Hr	Hrs)		7/0	77/0	77/0
**Temperature Cycle	-65C/+150C (500 Cyc)		77/0		77/0	77/0
Surface Mount Solderability	Pb Free/Solder-		15/0		15/0	-
Manufacturability (Assembly	<u> </u>	(per mfg. Site specification)			Pass	Pass
Moisture Sensitivity	(level 2 @ 260C peak +5/-0C)		12/0		12/0	12/0
Notes **- Preconditioning	sequence: Level 2-2600	<u> </u>				

Qualification Data: Group 2 Devices

	Quantication Data 1 Group 2 Devices						
This qualification has been developed for the validation of this change. The qualification data							
validates that the proposed change meets the applicable released technical specifications.							
Qual	Qual Vehicle 1: DRV91670PHPR (MSL 3-260C)						
Package Construction Details							
Assembly Site: 7	ΓΑΙ	Mold Compou	nd:	4205	443		
# Pins-Designator, Family: 4	18-PHP, HTQFP	Mount Compou	nd:	4208	458		
Lead frame (Finish, Base): N	NiPdAu, Cu	Bond Wi	ire:			Cu	
Qualification: Plan	☐ Test Results						
Deliability Test	Conditions		Sample Size/		Fail		
Reliability Test			Lot# 1		Lot# 2	Lot# 3	
Electrical Characterization	-		Pass		Pass	Pass	
**High Temp Storage Bake	170C (420 Hrs)		77/0		77/0	77/0	
**Autoclave	121C (96 Hrs)		77/0		77/0	77/0	
** Temperature Cycle	-65C/+150C (500 Cyc)			7/0	77/0	77/0	
ESD CDM	+/- 250V; +/- 1500V			3/0	-	-	
ESD HBM	+/- 1000V; +/- 2500V		3/0		-	-	
Manufacturability (Assembly)	(per mfg. Site specification)		Pass		Pass	Pass	
Moisture Sensitivity	(level 3 @ 260C peak	< +5/-0C)	12	2/0	-	-	
Notes **- Preconditioning sequence: Level 3-260C.							

Qualification Data: Group 3 Devices

Qualification Data: Group 3 Devices							
This qualification has been developed for the validation of this change. The qualification data							
validates that the proposed of	validates that the proposed change meets the applicable released technical specifications.						
Qual Vehicle 1: SN74AHC1G126DBVR (MSL 1-260C)							
Package Construction Details							
Assembly Site:	HNT	Mold Compou	nd:	4504	450413		
# Pins-Designator, Family:	5-DBV, SOT-23	Mount Compou	nd:	4001	00154		
Lead frame (Finish, Base):	NiPdAu, Cu	Bond Wire:		1.0 Mil Dia., C		u	
Qualification: Plan Test Results							
Deliebility, Teet	Conditions		Sample Size/Fail		'Fail		
Reliability Test			Lot# 1		Lot# 2	Lot# 3	
**High Temp Storage Bake	170C (600 Hrs)		82/0		85/0	84/0	
**Autoclave	121C (192 Hrs)		77/0		77/0	77/0	
** Temperature Cycle	-65C/+150C (500 Cyc)		77/0		77/0	77/0	
Moisture Sensitivity	(level 1 @ 260C peak +5/-0C)		22/0		22/0	22/0	
Notes **- Preconditioning	sequence: Level 1-2600	<u>.</u>	•		•		

Qual Vehicle 2: SN74CBTLV1G125DBVR (MSL 1-260C)							
	Package Constr	uction Details					
Assembly Site:	HNT	Mold Compou	nd: 450413				
# Pins-Designator, Family:	5-DBV, SOT-23	Mount Compour	400154				
Lead frame (Finish, Base):	NiPdAu, Cu	Bond Wi	ire:	0.8 N	1il Dia., C	u	
Qualification:	☐ Test Results				,		
Reliability Test	Conditions		Sample Size/Fail				
**High Temp Storage Bake	170C (600 Hrs)				90/0		
**Autoclave	121C (96 Hrs)				77/0		
**T/C -65C/150C	-65C/+150C (500 Cy	/c)			77/0		
	sequence: Level 1-2600	2.			•		
	Vehicle 3: SN74LVC1		260	C)			
	Package Constr	uction Details					
Assembly Site:	HNT	Mold Compour	nd:	4504	13		
# Pins-Designator, Family:	5-DBV, SOT-23	Mount Compour	nd:	4001	54		
Lead frame (Finish, Base):	NiPdAu, Cu	Bond Wi	re:	0.80	Mil Dia.,	Cu	
Qualification: Plan	☐ Test Results				,		
Delia Lilla . Tana	Canaditiana	Conditions		Sample Size/Fa			
Reliability Test	Conditions			t# 1	Lot# 2	Lot# 3	
**High Temp Storage Bake	170C (420 Hrs)		87/0		87/0	89/0	
**Autoclave	121C (192 Hrs)		77/0		77/0	77/0	
**Biased HAST	130C/85%RH (192 H	lrs)	8	0/0	80/0	80/0	
** Temperature Cycle	-65C/+150C (500 Cy	/c)	77/0		77/0	77/0	
Solderability	Pb Free/Solder	Pb Free/Solder			22/0	22/0	
Manufacturability (Assembly	(per mfg. Site specification)			ass	Pass	Pass	
Moisture Sensitivity	(level 1 @ 260C peak +5/-0C)			22/0 22		22/0	
Notes **- Preconditioning	sequence: Level 1-2600	<u>.</u>					
Q	ual Vehicle 4: TS321	LIDBVT (MSL 1-2600	2)				
	Package Constr	uction Details		•			
Assembly Site:	HNT	Mold Compound: 450		4504	50413		
# Pins-Designator, Family:	5-DBV, SOT-23	Mount Compound: 400154		54			
Lead frame (Finish, Base):	NiPdAu, Cu	Bond Wire: 1.0 Mil Dia., Cu				u	
Qualification: Plan	☐ Test Results						
				Sample Size/Fail			
Reliability Test	Conditions		Lot# 1		Lot# 2	Lot# 3	
**High Temp Storage Bake	170C (420 Hrs)		79/0		80/0	80/0	
**Autoclave	121C (192 Hrs)			7/0	77/0	77/0	
** Temperature Cycle	-65C/+150C (500 Cy	•			77/0	77/0	
Moisture Sensitivity	(level 1 @ 260C peak +5/-0C)			7/0 2/0	22/0	22/0	
Notes **- Preconditioning sequence: Level 1-260C.							
	-						

Qual Vehicle 5: TS5A3166DBVR (MSL 1-260C)							
Package Construction Details							
Assembly Site:	HNT	Mold Compoun	d: 450413				
# Pins-Designator, Family:	5-DBV, SOT-23	Mount Compoun	d: 400154				
Lead frame (Finish, Base):	NiPdAu, Cu	Bond Wir	e: 0.8 Mil Dia., Cu				
Qualification: Plan Test Results							
Reliability Test	Conditions		Sample Size/Fail				
**Autoclave	121C (96 Hrs)		77/0				
** Temperature Cycle	-65C/+150C (500 Cy	rc)	77/0				
Notes **- Preconditioning sequence: Level 1-260C.							

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

Location	E-Mail
USA	PCNAmericasContact@list.ti.com
Europe	PCNEuropeContact@list.ti.com
Asia Pacific	PCNAsiaContact@list.ti.com
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